

Notice of References Cited	Application/Control No. 10/785,993	Applicant(s)/Patent Under Reexamination OKUDA ET AL.	
	Examiner Dr. Kelechi C. Egwim	Art Unit 1713	Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,767,206	06-1998	Ariagno et al.	525/479
	B	US-5,532,302	07-1996	Nakanishi et al.	524/143
	C	US-5,179,144	01-1993	Yamamoto et al.	524/114
	D	US-4,994,523	02-1991	Sasaki et al.	525/63
	E	US-4,994,522	02-1991	Sasaki et al.	525/63
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 03281556 A	12-1991	Japan	NAKAURA et al.	C08L 27/06
	O	JP 04018009 A	01-1992	Japan	IIDA et al.	A61K 07/00
	P	JP 04261454 A	09-1992	Japan	NAKAMURA et al.	C08L 33/06
	Q	JP 08199026 A	08-1996	Japan	FUJII et al.	C08L 25/08
	R	JP 09020852 A	01-1997	Japan	NODA et al.	C08L 27/06
	S	JP 09208889 A	08-1997	Japan	MATSUMOTO et al.	C09D151/08
	T	JP 09208890 A	08-1997	Japan	MATSUMOTO et al.	C09D155/00

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/785,993	Applicant(s)/Patent Under Reexamination OKUDA ET AL.	
	Examiner Dr. Kelechi C. Egwim	Art Unit 1713	Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 09217282 A	08-1997	Japan	MATSUMOTO et al.	D06M 15/643
	O	JP 09241465 A	09-1997	Japan	NODA, OSAYASU	C08L 27/06
	P	JP 10280829 A	10-1998	Japan	ENDO et al.	E06B 07/22
	Q	JP 09328616 A	12-1997	Japan	MATSUMOTO et al.	C08L 83/10
	R	JP 06279232 A	10-1994	Japan	IIDA et al.	A61K 07/00
	S	JP 06179788 A	06-1994	Japan	OHATA et al.	C08L 27/06
	T	JP 2000143884 A	05-2000	Japan	NODA, OSAYASU	C08L 23/00

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/785,993	Applicant(s)/Patent Under Reexamination OKUDA ET AL.	
	Examiner Dr. Kelechi C. Egwim	Art Unit 1713	Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000143884 A	05-2000	Japan	NODA, OSAYASU	C08L 23/00
	O	JP 2000086429 A	03-2000	Japan	MIYAGAWA et al.	A61K 07/00
	P	JP 2001158845 A	06-2001	Japan	NAKAI et al.	C08L 51/00
	Q	JP 2003096142 A	04-2003	Japan	TATSUTA et al.	C08F283/12
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.